

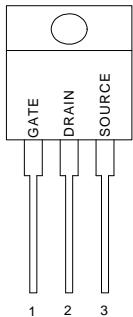


GENERAL DESCRIPTION

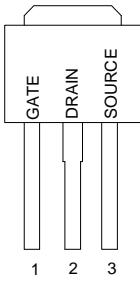
This advanced high voltage MOSFET is designed to withstand high energy in the avalanche mode and switch efficiently. This new high energy device also offers a drain-to-source diode with fast recovery time. Designed for high voltage, high speed switching applications such as power supplies, converters, power motor controls and bridge circuits.

PIN CONFIGURATION

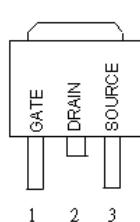
TO-220 / TO-220FP
Front View



TO-251
Front View



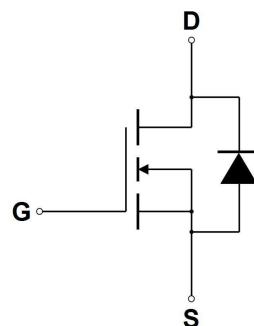
TO-252
Front View



FEATURES

- ◆ SJ MOS
- ◆ Higher Current Rating
- ◆ Lower R_{d(on)}
- ◆ Lower Capacitances
- ◆ Lower Total Gate Charge

SYMBOL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain to Current — Continuous	I _{D(1)}	13.8	A
— Pulsed	I _{DM}	41.4	
Gate-to-Source Voltage — Continue	V _{GS}	±20	V
Total Power Dissipation TO-251/TO-252	P _D	100	
TO-220		167	W
TO-220FP		35	
Derate above 25°C	TO-251/TO-252	0.8	
TO-220		1.33	W/°C
TO-220FP		0.28	
Junction and Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C
Single Pulse Drain-to-Source Avalanche Energy — T _J = 25°C (V _{DD} = 100V, V _{GS} = 10V, I _L = 3.0A, L = 10mH, R _G = 25Ω)	E _{AS}	145	mJ
Thermal Resistance — Junction to Case TO-251/TO-252	θ _{JC}	1.25	
TO-220		0.75	
TO-220FP		3.6	°C/W
— Junction to Ambient TO-251/TO-252/ TO-220/ TO-220FP	θ _{JA}	62.5	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T _L	260	°C

(1) Drain current limited by maximum junction temperature (TO220)



ORDERING INFORMATION

Part Number	TOP MARK	Part Number	Packing Mthod	Note
GWM14S60YRE	GWM14S60Y	TO-251	Tube	
GWM14S60YRD	GWM14S60Y	TO-252	Tube	
GWM14S60YRDTR	GWM14S60Y	TO-252	Tape and Reel	
GWM14S60YRY	GWM14S60Y	TO-220	Tube	
GWM14S60YRX	GWM14S60Y	TO-220FP	Tube	

Note1: Halogen Free and PB Free Product

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, $T_J = 25^\circ\text{C}$

Characteristic		Symbol	Min	Typ	Max	Units
Drain-Source Breakdown Voltage ($V_{GS} = 0 \text{ V}$, $I_D = 250 \mu\text{A}$)		$V_{(BR)DSS}$	600			V
Drain-Source Leakage Current ($V_{DS} = 600 \text{ V}$, $V_{GS} = 0 \text{ V}$)		I_{DSS}			1	μA
Gate-Source Leakage Current-Forward ($V_{GSF} = 20 \text{ V}$, $V_{DS} = 0 \text{ V}$)		I_{GSSF}			100	nA
Gate-Source Leakage Current-Reverse ($V_{GSR} = -20 \text{ V}$, $V_{DS} = 0 \text{ V}$)		I_{GSSR}			100	nA
Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$)		$V_{GS(th)}$	2	3	4	V
Static Drain-Source On-Resistance ($V_{GS} = 10 \text{ V}$, $I_D = 4.7\text{A}$) *		$R_{DS(on)}$			0.35	Ω
Input Capacitance	$(V_{DS} = 100 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1.0 \text{ MHz}$)	C_{iss}		652		pF
Output Capacitance		C_{oss}		38		pF
Reverse Transfer Capacitance		C_{rss}		1		pF
Turn-On Delay Time	$(V_{DD} = 300 \text{ V}$, $I_D = 7 \text{ A}$, $V_{GS} = 10 \text{ V}$, $R_G = 9.1\Omega$) *	$t_{d(on)}$		16.6		ns
Rise Time		t_r		38.2		ns
Turn-Off Delay Time		$t_{d(off)}$		49.9		ns
Fall Time		t_f		38.9		ns
Total Gate Charge	$(V_{DS} = 480 \text{ V}$, $I_D = 7\text{A}$, $V_{GS} = 10 \text{ V}$) *	Q_g		18.83		nC
Gate-Source Charge		Q_{gs}		3.79		nC
Gate-Drain Charge		Q_{gd}		7.29		nC
SOURCE-DRAIN DIODE CHARACTERISTICS						
Forward On-Voltage(1)	$(I_S = 4.7\text{A}$, $d_{IS}/d_t = 100\text{A}/\mu\text{s}$)	V_{SD}			1.5	V
Forward Turn-On Time		t_{on}		**		ns
Reverse Recovery Time		t_{rr}		203.26		ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

** Negligible, Dominated by circuit inductance



TYPICAL ELECTRICAL CHARACTERISTICS

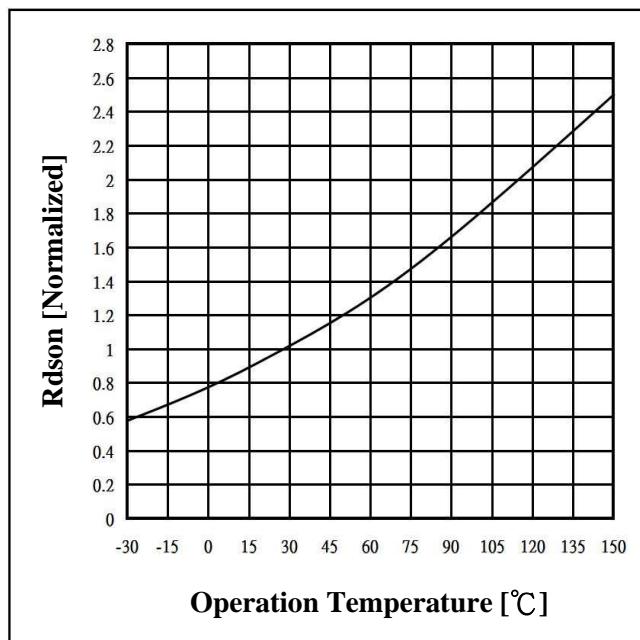


Fig.1. On-Resistance Variation with vs. Temperature

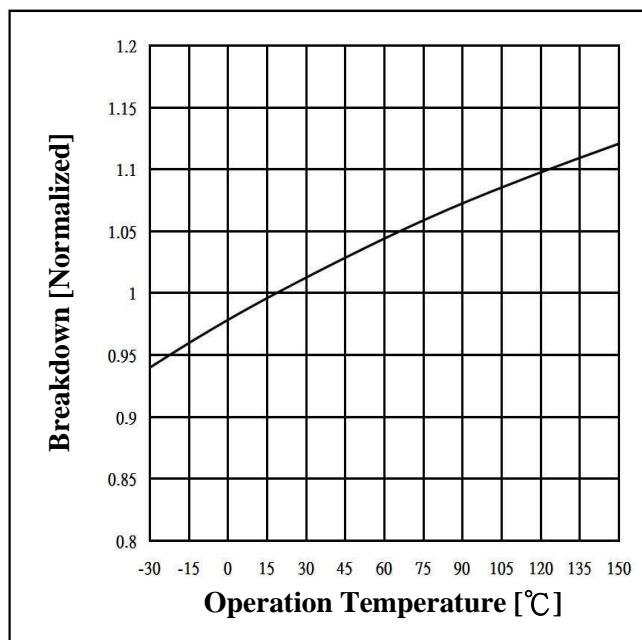


Fig.2 Breakdown Voltage Variation vs. Temperature

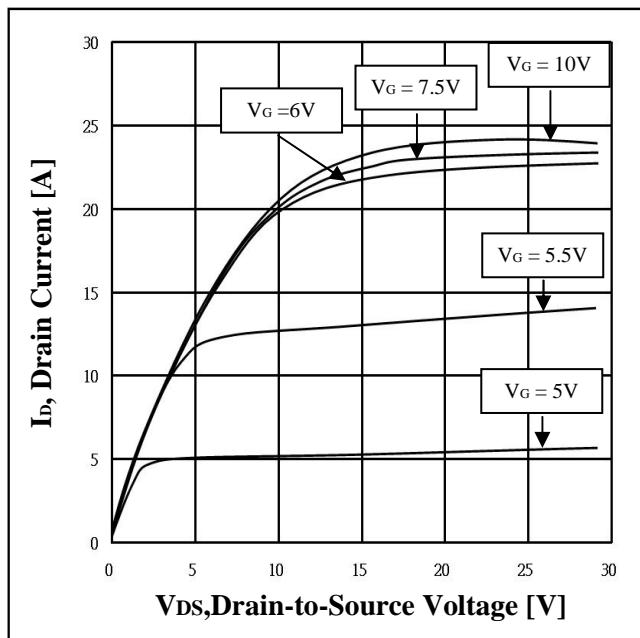


Fig.3. Typical Output Characteristics

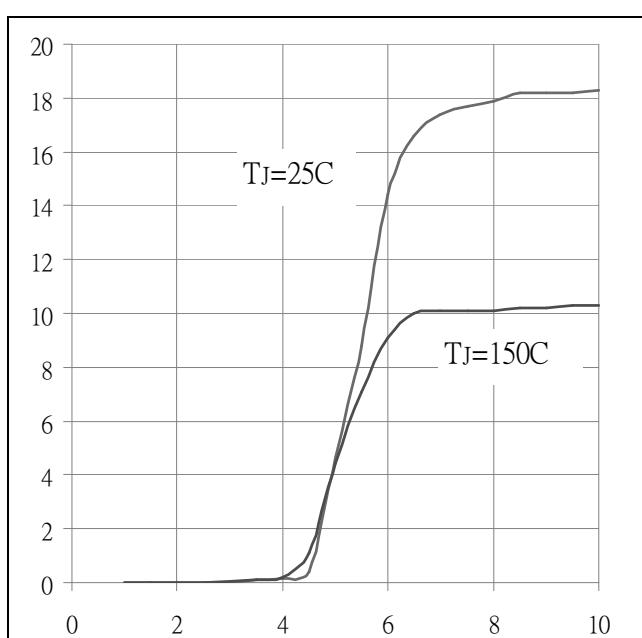
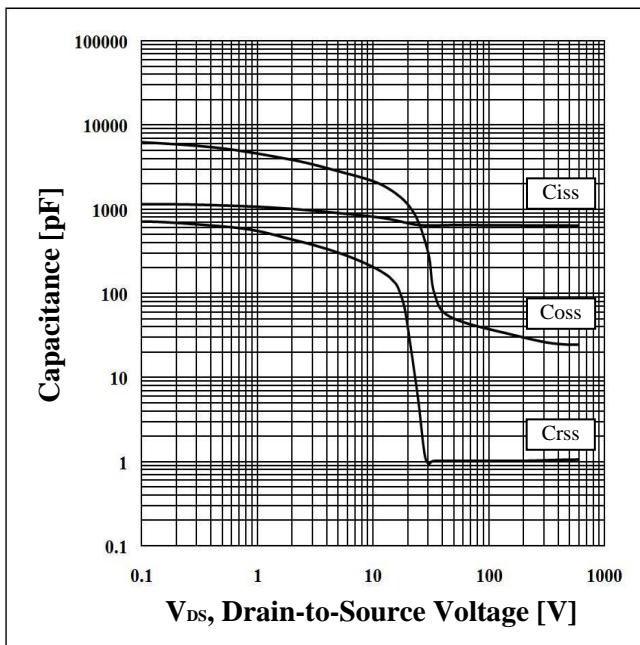


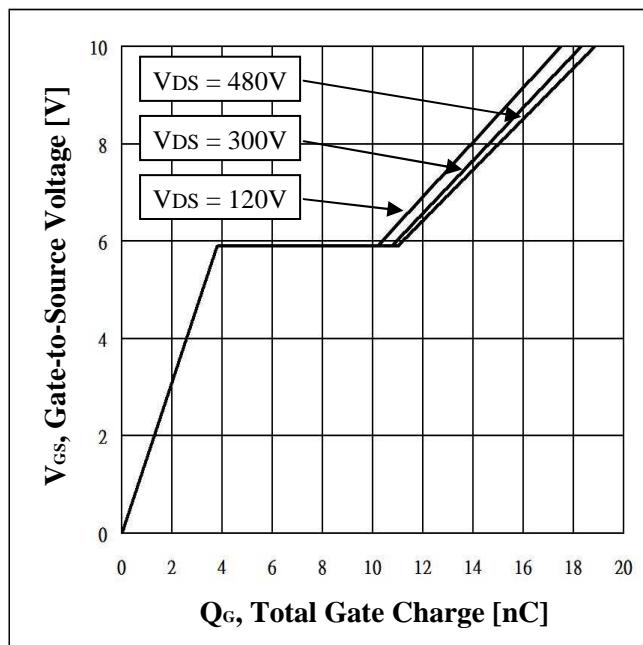
Fig.4. Typical Transfer Characteristics



GWM14S60Y
POWER FIELD EFFECT TRANSISTOR



**Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage**



**Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage**